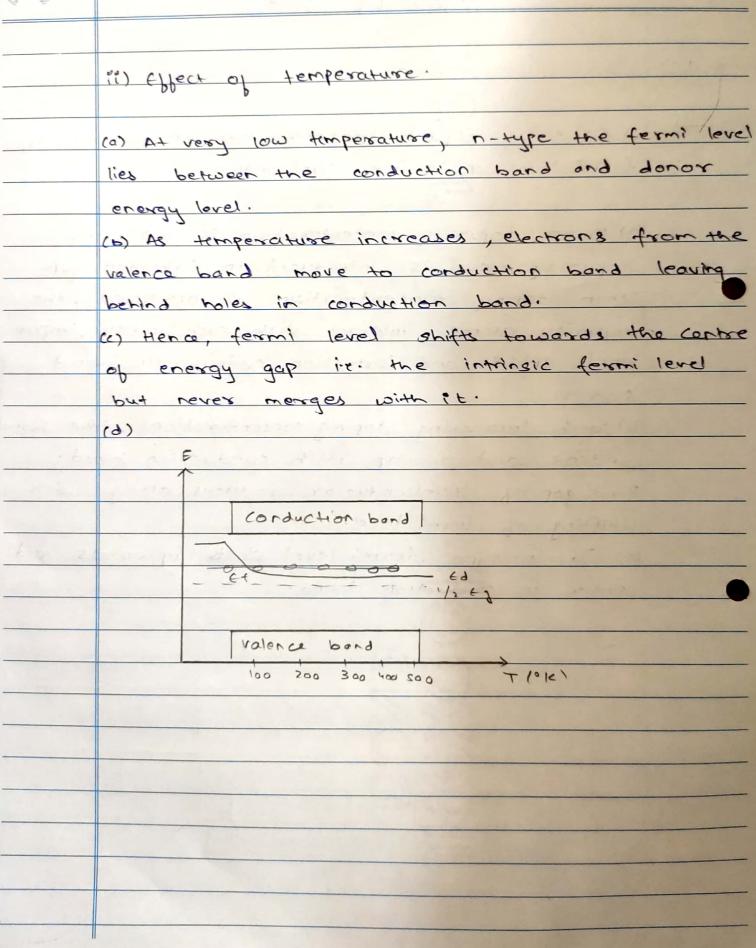


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	1. Post 1.
Control of the Contro	Engineering Physics. MAEER'S MIT
	Julie of the second of the sec
Q. 10>	
\rightarrow	i) Effect of dopant concentration on position of
	fermi level of ntime semiconductor.
_	(6) When impurity concentration is low, the
	impurity level Ps introduced in forbidden gap.
	when doping concentration is increased, the
	impurity atoms interact with each other, impurity
- 4.11	level splits and formation of impurity band
	starts.
	(b) with increasing doping concenterations, the band
	widens and overslop with conduction band.
	Band gap of semiconductor reduces along with
A Line of	
THE STATE OF	(c) In n-type termi level shifts upwards and
	3
	enter in conduction band.
	1
	conduction conduction land
	band bond &
	0 - 0 60
	€D
	1 6 8
	valence band valence band.
	Light dopping medium doping Heavy doping





1. b) Cren: a = 1.5A, b = 2A, C = 2A
Trescepts, m= -1.5A, n= 1A, P= CD
. Intercepts in terms of lattice parameter,
$\begin{array}{cccccccccccccccccccccccccccccccccccc$
:. Reciprocal: -1,2,0
co.
indices of plane are (0) (T,2,0)
Z
(120)
\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \
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A	MALLINSIMIT
Q. 2 a>	Derive Schrodinger time independent wove equation
\longrightarrow	i) The general differential equation of a mother wave travelling in x-direction is given by
	$\frac{3^2 \psi}{3^2 \psi} = \frac{3^2 \psi}{1 \cdot 3^2 \psi} = $
•	The general colution of above equation is of the form $ \varphi = \varphi_0 e^{i(kx-\omega t)} $ (i) where $\varphi_0 = a$ constant.
	2) Differentiating the equation partially wit to t, $\frac{\partial \Psi}{\partial t} = (-i\omega) \forall o e^{(kx-\omega t)} - (3)$
27	3) Differentiating the eq (2) partially wit t,
•	$\frac{3^2 \Psi}{\partial t^2} = \frac{(-i\omega)^2 \Psi_0}{(-i\omega)^2} = \frac{\pounds(\kappa x - \omega t)}{(-i\omega)^2 \Psi_0}$
	= - w2 40 e (kx-wt) = - w2 40 - (35) (4)
	Substituting Pr equation (i) we get,
	$\frac{3^2\psi}{3\times^2} = -\omega^2 \psi$



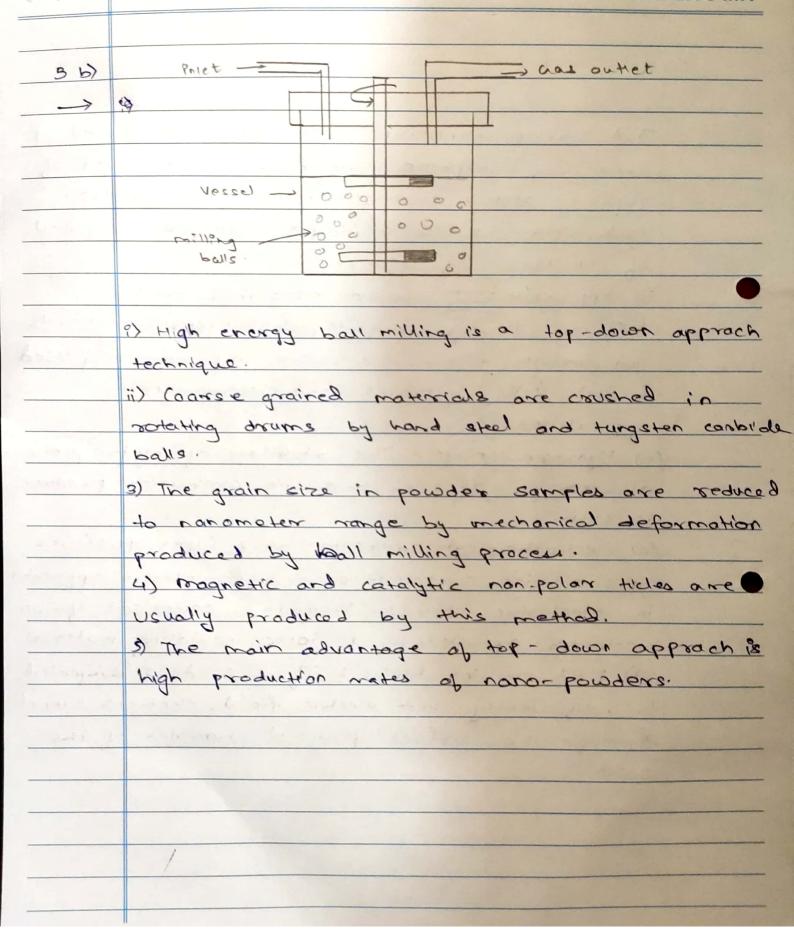
	WALLING WILL
	iv) But was a real and a series of a frequency
	iv) But w= 2 Tru, where v = frequency
2	·· W - 2T
	$\frac{1}{\omega^2} = 4\pi^2 \qquad -15$
Action .	U2 = 12
	v) By de-Broglie hypothesis, d = h
	P
	:. Substituting value of in eq(5)
	$\frac{1}{u^2} = 4\pi^2 p^2 - (6)$
	vi) Total energy = Kinchic energy + Potential energy
	:. TE = 1mv2 + P.E
	= 1 m3/3 + be
	2m (P=mv)
	P = 2m (TE-PE)
	vii) Substituting in equation (f), $\omega^2 = 8\pi^2 m \ (TE-PE)$ $u^2 = h^2$
	$u^2 = h^2$

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	Viii) Substituting in eq (4),
	$\frac{\partial^2 \Psi}{\partial x^2} = -8\pi^2 m \left(T \in -P \in \right) \cdot \Psi$
	1. 324 813m (IE- DE) Φ = 0
•	The above equation is used when PE is constant in time but varies in space.
	Replacing the above equation by total derivative,
	3x2 + 8πm (TE-PE) Ψ = 0
0	



Q-3 (a)	
>	i) A carbon nanotube is a cylindrical rolled up
	cheet of graphene, which is single layer of
	graphete atoms arranged in hexagonal pattern.
	fach ranotube is a single molecule composed
	of millions of atoms.
	ii) Applications of corbon nanotubes are:
the man	(a) Energy storage graphite, carbonaceous materials
	and carbon fibre electrodes are commonly used
	In fuel cells, battraies and electromagnetic
Maria Ba	applications.
	(b) Hydrogen storage: The advantage of hydrogen
alari y	as energy source is that its combution product
	ic water.
	(c) Hectrochemical supercapacitors: Supercapacitors
	have a high capacitance and potentially applicable
	in electronic device. They are comprised of two
	electrodes seperated by a ionic insulating material.
	(d) Field emitting device: The solld is subjected
	to a subjiciently high electric field, electrons tunnel
	through the surface potential barrier of the
	solid.





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Q . 5 a>	
4 4 4	
\rightarrow	
	i) The production of potential difference across
	on electrical conductor when a magnetic field
	is applied in a direction perpendicular
- Land	bestergicular to that of flow marent.
	2) let VH = Hall voltage.
	: EH = Hectoic Potensity = VH
	Under equilibrium, forces on the charge corrier q
	due to the electric field and magnetic field
	will be equal.
	. Q.EH = QVB
	CH = VB
	VH = VB or VH = VBd
•	d
	We know that, I=nqqv
	V = 1
	naa
	Putting this 9n equation, we get
	VH = IBd . Further as x=wxd
	nqa
	VH = IB
	na/m
-	



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we also know that current density, J= I
: Subott to ting in above expression,
VH = IBd BJd
VH = IBd BJd Na = Na
'VH = BVd = IB = BJd is the required
expression for hall voltage.
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Q.5b)	
\rightarrow	We know that
	E = hc - (1)
	4
	and, DE. Dt > h - (2)
	ЧП
	where $06 = h \cdot (0.44 - 0.01)$
	42
-	from eq. (i), (2) and (3)
-	
	hc dd
	$\frac{1}{1} \cdot \Delta t = \left(\frac{4\pi}{4\pi}\right) \cdot \left(\frac{C\Delta \lambda}{1}\right)$
	D+ Ω (646)2 × 1
	4π 3×10 ⁸ ×16 ⁻¹⁹
-	
	C(46 × 10-9)2 × 1 477 3× 108 × 10-14
	3 x 10° x 16° '
	V 110/9.15 412
	∴ 1069.65 ×10 ⁻¹² ∴ 0+ 5 11 × 10 ⁻⁹ s.
	1 X 10 S.
-	

	Div - JI
19/05/2021	Engineering Physics -1
Q.4 a>	What is fringe width? Derive the expression for
	fringe width of wedge shaped film.
	i) The distance between two consecutive bright or
-	dork fringes is called the fringe width. The
	fringe formed at the centre of the fringe
	pattern is called central bright fringe.
125	2) For the wedge-shaped film, we have for nth
	maxlmum,
	2 ut cos(r+0) = (2n-1) d
	For normal incidence and air film,
	T=0 and U=1
	: 2+(660 = (2n-1) d - (i)
	where t is thickness.
	The nth bright band is produced at a distance to
	from the edge of the wedge.
	grow the eage of the week
-	t = xn tano - (2)
- R MC /	
-	Substituting for t in eq (i),
	2×ntano coso = (2n-1)d
	2
214	$2 \times n \sin \theta = (2n-1) \frac{1}{2} - (3)$
	2 / 11 3 / 2

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